Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/760,538	YOUN, JEONG CHAE
Examiner	Art Unit
MUHAMMAD N. EDUN	2627

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SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
(see sear	PUBS ONLY ch history tout)	3/30/2007	ME

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	DATE	EXMR
WEST (see search history printout)	3/30/2007	ME